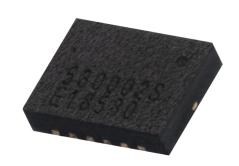


CMPA0530002S

2 W, 0.5 - 3.0 GHz, 28 V, GaN MMIC

Description

The CMPA0530002S is a packaged gallium nitride (GaN) High Electron Mobility Transistor (HEMT) based monolithic microwave integrated circuit (MMIC). The MMIC power amplifier is matched to 50-ohms on the input. The CMPA0530002S operates on a 28 volt rail while housed in a 3mm x 4mm; surface mount; dual-flat-no-lead (DFN) package. Under reduced power; the transistor can operate below 28V to as low as 20V V_{DD} ; maintaining high gain and efficiency.



Package Type: 3x4 DFN PN: CMPA0530002S

Typical Performance Over 0.5 - 3.0 GHz ($T_c = 25^{\circ}\text{C}$), 28 V

Parameter	0.5 GHz	1.0 GHz	1.5 GHz	2.0 GHz	2.5 GHz	3.0 GHz	Units
Small Signal Gain	18.10	17.90	18.30	17.90	17.90	17.52	dB
Output Power ¹	2.85	2.80	2.99	2.99	2.84	2.90	W
Power Gain ¹	13.05	12.97	13.26	13.25	13.04	13.12	dB
Power Added Efficiency ¹	56.0	48.7	56.2	51.2	46.0	49.1	%

 1 Note: $P_{IN} = 21.5 dBm$, CW

Features for 28 V in CMPA0530002S-AMP

- 18 dB Small Signal Gain
- 2.9 W Typical P_{SAT}
- Operation up to 28 VHigh Breakdown Voltage
- High Temperature Operation
- Size 0.118 x 0.157 x 0.033 inches

Applications

- Civil and Military Communications
- Broadband Amplifiers
- Electronic Warfare
- Industrial, Scientific & Medical
- Radar



RoHS compliant



Absolute Maximum Ratings (not simultaneous) at 25°C Case Temperature

Parameter	Symbol	Rating	Units	Conditions
Drain-Source Voltage	V_{DSS}	84	W	25°C
Gate-to-Source Voltage	V _{GS}	-10, +2	V	25°C
Storage Temperature	T _{STG}	-65, +150	°C	
Operating Junction Temperature	TJ	225	٠٠٠	
Maximum Forward Gate Current	I _{GMAX}	0.8	mA	2500
Maximum Drain Current ¹	I _{DMAX}	0.33	А	- 25°C
Soldering Temperature ²	Ts	245	°C	
Thermal Resistance, Junction to Case ⁵	$R_{\theta JC}$	24.0	°C/W	85°C

Notes:

Electrical Characteristics (T_c = 25°C), 28 V Typical

Characteristics	Symbol	Min.	Тур.	Max.	Units	Conditions	
DC Characteristics ¹							
Gate Threshold Voltage	$V_{GS(th)}$	-3.6	-3.1	-2.4	V	$V_{DS} = 10 \text{ V}, I_{D} = 0.8 \text{ mA}$	
Gate Quiescent Voltage	$V_{GS(Q)}$	ı	-2.4	_	mA	$V_{DS} = 28 \text{ V}, I_{D} = 90 \text{ mA}$	
Saturated Drain Current ²	I _{DS}	0.58	0.8	_	Α	$V_{DS} = 6.0 \text{ V}, V_{GS} = 2.0 \text{ V}$	
Drain-Source Breakdown Voltage	$V_{BR(DSS)}$	84	_	_	V	$V_{GS} = -8 \text{ V}, I_D = 0.8 \text{ mA}$	
RF Characteristics ^{3,4} (T _c = 25°C, F ₀ = 3.0 GHz unless otherwise noted)							
Small Signal Gain	S ₂₁	ı	16.4	_			
Input Return Loss	S ₁₁	ı	-19.3	_	dB		
Output Return Loss	S ₂₂	_	-14.7	_		$V_{DS} = 28 \text{ V}, I_{DQ} = 90 \text{ mA}$	
Output Power	P _{out}	_	33.5	_	dBm		
Drain Efficiency	η	_	52	-	%		
Output Mismatch Stress	VSWR	_	_	10:1	Ψ	No damage at all phase angles, $V_{DD} = 28 \text{ V}$, $I_{DQ} = 90 \text{ mA}$, $P_{IN} = 23 \text{ dBm}$	

Notes:

¹ Current limit for long term, reliable operation

² Refer to the Application Note on soldering

 $^{^3}$ Simulated at P_{DISS} = 2.2 W

⁴T_C = Case temperature for the device. It refers to the temperature at the ground tab underneath the package. The PCB will add additional thermal resistance

 $^{^5}$ The R_{TH} for the application circuit, CMPA0530002S-AMP1, with 15 (Ø13 mil) via holes designed on a 20 mil thick Rogers 4350B PCB, is 24°C/W. The total R_{TH} from the heat sink to the junction is 24°C/W + 6.5°C/W = 30.5°C/W

¹ Measured on wafer prior to packaging.

² Scaled from PCM data

³ Measured in CMPA0530002S high volume test fixture at 3.0 GHz and may not show the full capability of the device due to source inductance and thermal performance.

 $^{^4}$ P_{IN} = 23 dBm, CW



Electrical Characteristics When Tested in CMPA0530002S-AMP1 at 0.5 - 3.0 GHz, CW

Characteristics	Symbol	Тур.	Max.	Units	Conditions	
RF Characteristics 1 (T _c = 25 $^{\circ}$ C, F $_0$ = 0.5 - 3.0 GHz unless otherwise noted)						
Gain ²	G	13.2		dB		
Output Power ²	Роит	34.6	-	dBm	$V_{DD} = 28 \text{ V}, I_{DQ} = 90 \text{ mA}, P_{IN} = 21.5 \text{ dBm}$	
Power Added Efficiency ²	η	51	-	%		
Output Mismatch Stress ²	VSWR	_	10:1	Ψ	No damage at all phase angles, $V_{DS} = 28 \text{ V}, I_{DQ} = 90 \text{ mA}$	

Notes

¹ Measured in CMPA0530002S-AMP1 Application Circuit

² CW



Test conditions unless otherwise noted: V_{DD} = 28 V, I_{DO} = 90 mA, CW, P_{IN} = 21.5 dBm, Frequency = 2 GHz, T_{BASE} = +25°C

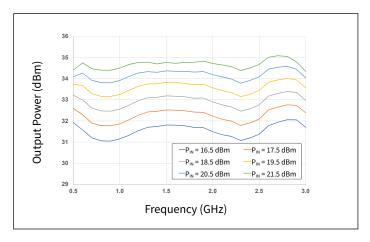


Figure 1. Output Power vs Frequency as a Function of Input Power

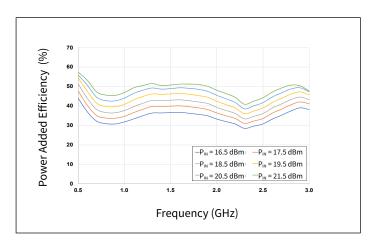


Figure 2. Power Added Efficiency vs Frequency as a Function of Input Power

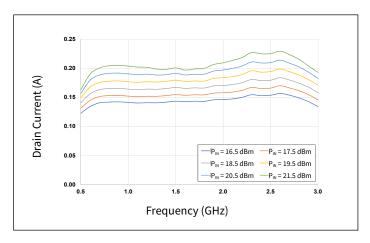


Figure 3. Drain Current vs Frequency as a Function of Input Power

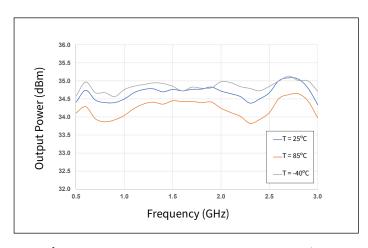


Figure 4. Output Power vs Frequency as a Function of Temperature

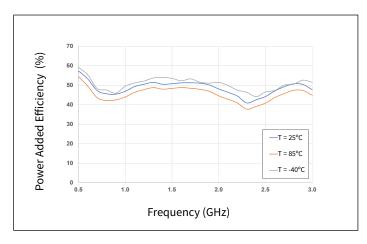


Figure 5. Power Added Efficiency vs Frequency as a Function of Temperature

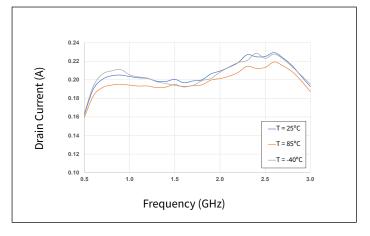


Figure 6. Drain Current vs Frequency as a Function of Temperature

4



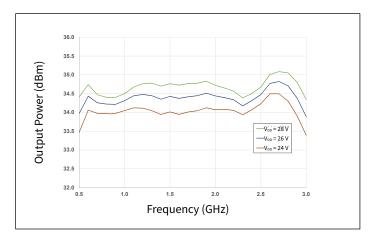


Figure 7. Output Power vs Frequency as a Function of Drain Voltage

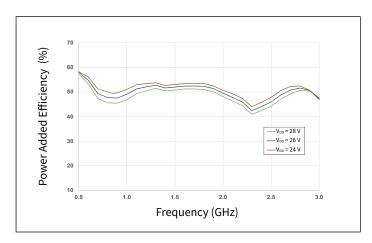


Figure 8. Power Added Efficiency vs Frequency as a Function of Drain Voltage

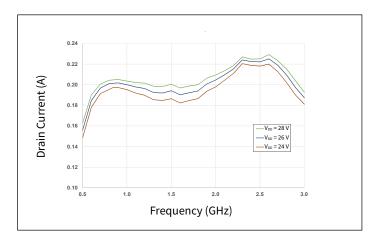


Figure 9. Drain Current vs Frequency as a Function of Drain Voltage

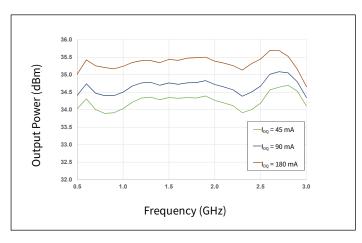


Figure 10. Output Power vs Frequency as a Function of IDO

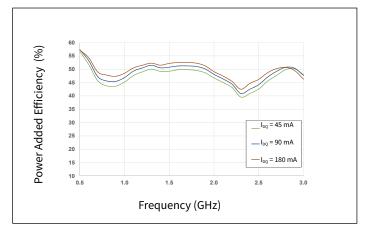


Figure 11. Power Added Efficiency vs Frequency as a Function of IDO

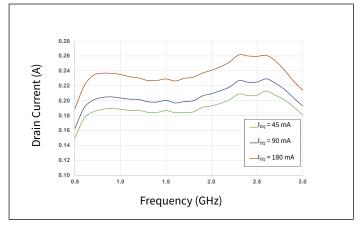


Figure 12. Drain Current vs Frequency as a Function of I_{DO}





Figure 13. Output Power vs Input Power as a Function of Frequency

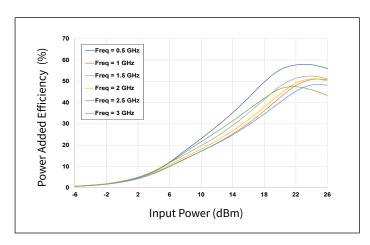


Figure 14. Power Added Efficiency vs Input Power as a **Function of Frequency**

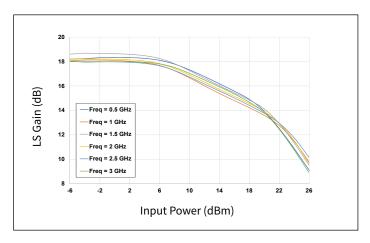


Figure 15. Large Signal Gain vs Input Power as a Function of Frequency

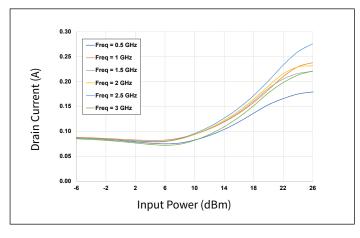


Figure 16. Drain Current vs Input Power as a Function of Frequency

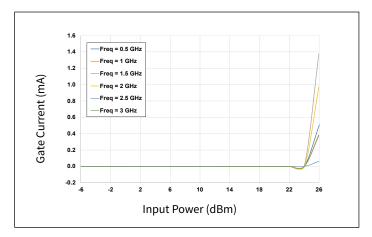


Figure 17. Gate Current vs Input Power as a Function of Frequency

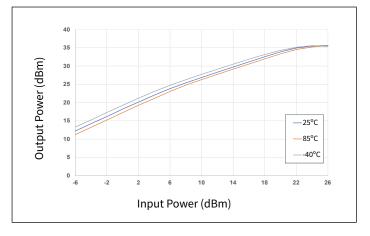


Figure 18. Output Power vs Input Power as a Function of Temperature



Test conditions unless otherwise noted: V_{DD} = 28 V, I_{DO} = 90 mA, CW, P_{IN} = 21.5 dBm, Frequency = 2 GHz, T_{BASE} = +25°C

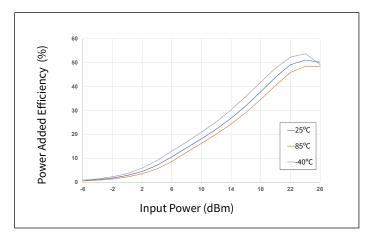


Figure 19. Power Added Efficiency vs Input Power as a **Function of Temperature**

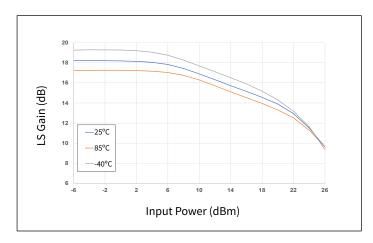


Figure 20. Large Signal Gain vs Input Power as a Function of **Temperature**

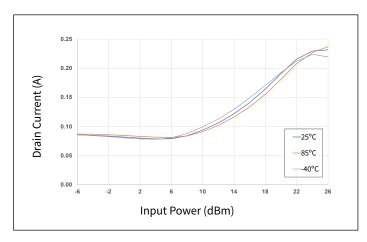


Figure 21. Drain Current vs Input Power as a Function of Temperature

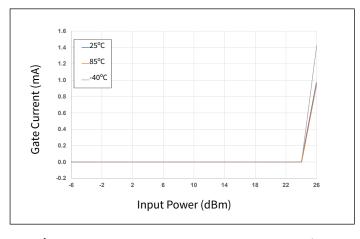


Figure 22. Gate Current vs Input Power as a Function of Temperature

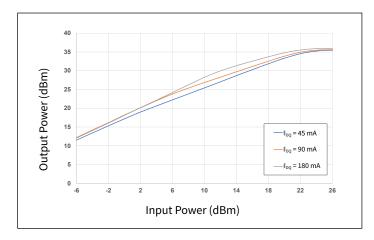


Figure 23. Output Power vs Input Power as a Function of IDO

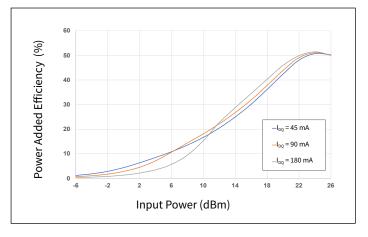


Figure 24. Power Added Efficiency vs Input Power as a Function of I_{DO}



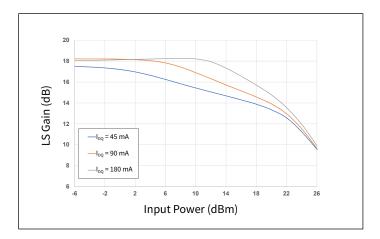


Figure 25. Large Signal Gain vs Input Power as a Function of I_{DO}

Figure 26. Drain Current vs Input Power as a Function of IDQ

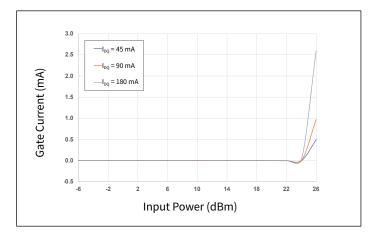


Figure 27. Gate Current vs Input Power as a Function of IDQ



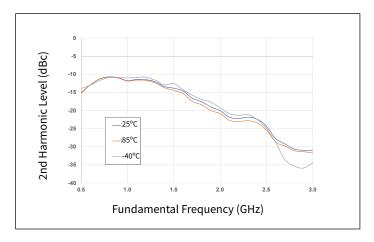


Figure 28. 2nd Harmonic vs Frequency as a Function of Temperature

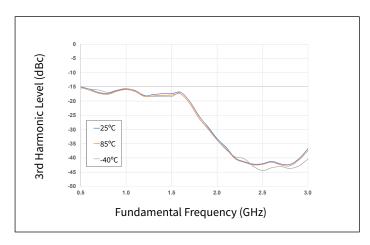


Figure 29. 3rd Harmonic vs Frequency as a Function of Temperature

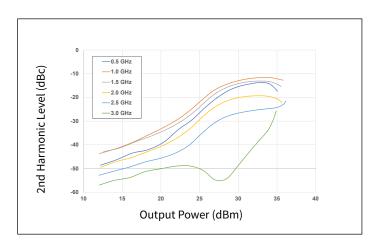


Figure 30. 2nd Harmonic vs Output Power as a Function of Frequency

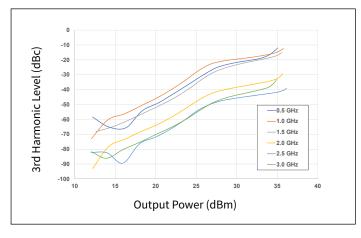


Figure 31. 3rd Harmonic vs Output Power as a Function of Frequency

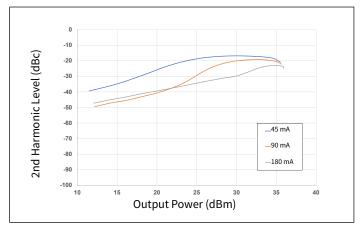


Figure 32. 2nd Harmonic vs Output Power as a Function of IDO

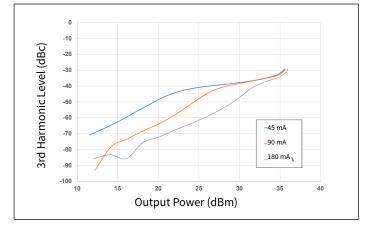


Figure 33. 3rd Harmonic vs Output Power as a Function of IDO



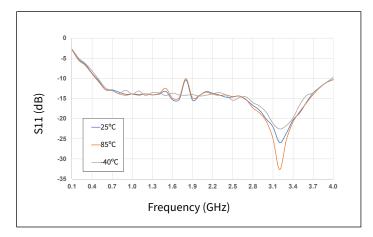


Figure 34. Input RL vs Frequency as a Function of Temperature

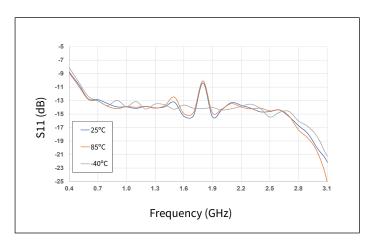


Figure 35. Input RL vs Frequency as a Function of Temperature

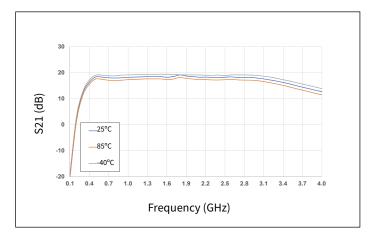


Figure 36. Gain vs Frequency as a Function of Temperature

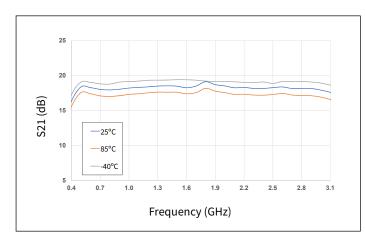


Figure 37. Gain vs Frequency as a Function of Temperature

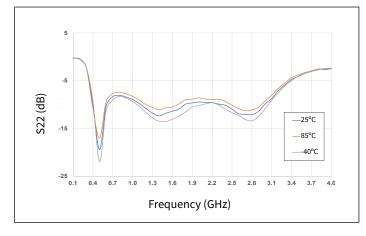


Figure 38. Output RL vs Frequency as a Function of Temperature

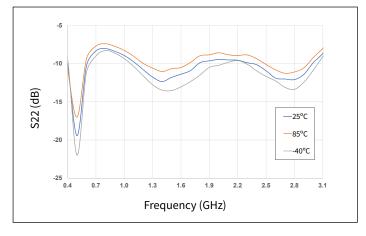


Figure 39. Output RL vs Frequency as a Function of Temperature



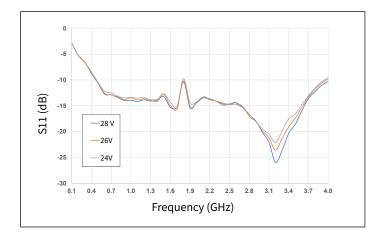
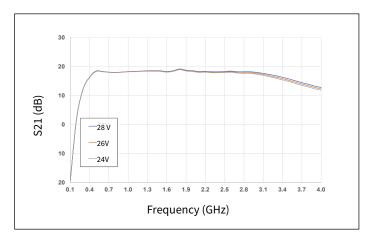


Figure 40. Input RL vs Frequency as a Function of Drain Voltage

Figure 41. Input RL vs Frequency as a Function of Drain Voltage



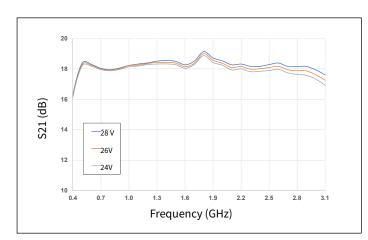
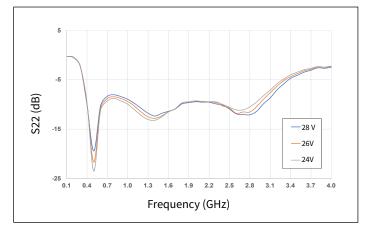


Figure 42. Gain vs Frequency as a Function of Drain Voltage

Figure 43. Gain vs Frequency as a Function of Drain Voltage



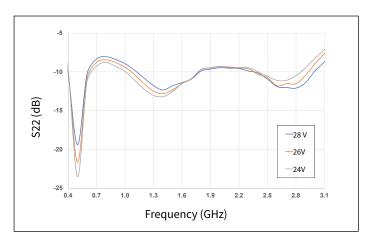


Figure 44. Output RL vs Frequency as a Function of Drain Voltage

Figure 45. Output RL vs Frequency as a Function of Drain Voltage



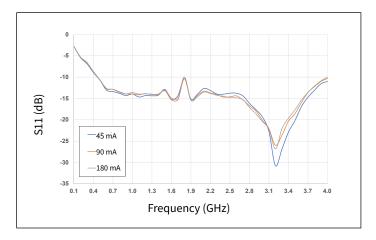


Figure 46. Input RL vs Frequency as a Function of IDQ

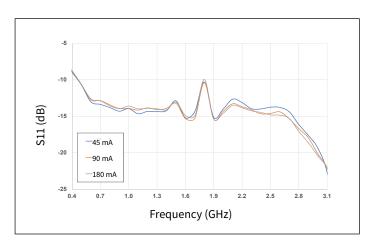


Figure 47. Input RL vs Frequency as a Function of I_{DO}

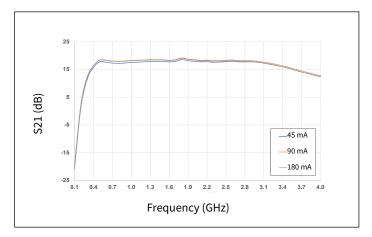


Figure 48. Gain vs Frequency as a Function of IDQ

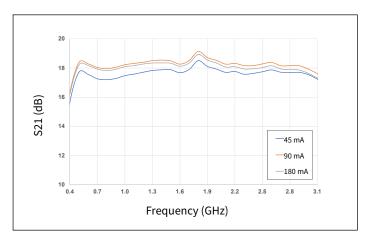


Figure 49. Gain vs Frequency as a Function of IDO

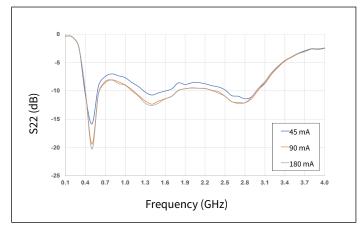


Figure 50. Output RL vs Frequency as a Function of I_{DO}

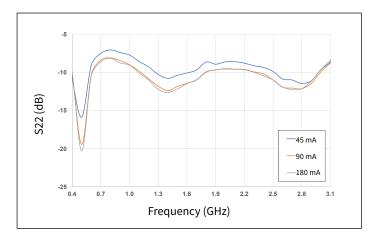


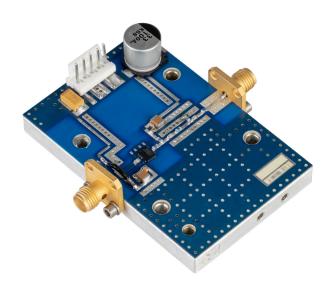
Figure 51. Output RL vs Frequency as a Function of IDQ



CMPA0530002S-AMP1 Application Circuit Bill of Materials

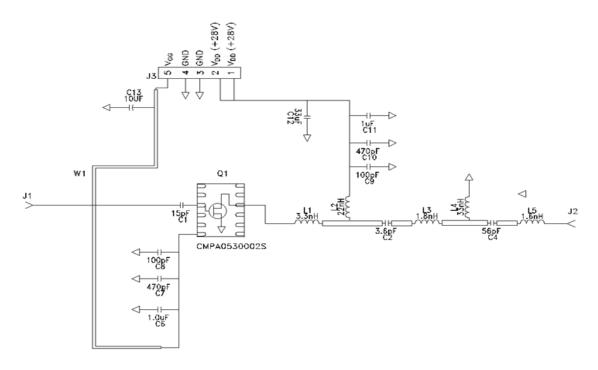
Designator	Description	Qty
C1	CAP, 15pF, 5%, 0603, ATC600S	1
C2	CAP, 3.6pF, 5%, 0603, ATC600S	1
C4	CAP, 56pF, 5%, 0603, ATC600S	1
C8, C9	CAP, 100pF, 5%, 0603, ATC600S	2
C7, C10	CAP, 470pF, 5%, 100V, 0603, X7R, AVX	2
C6, C11	CAP, 1.0μF, 100V, 10%, X7R, 1210, muRata	2
C12	CAP, 33μF, 20%, G CASE, Panasonic	1
C13	CAP, 10µF, 16V, TANTALUM, 2312, AVX	1
L1	INDUCTOR, CHIP, 3.3nH, 0603 SMT, Coilcraft	1
L2	INDUCTOR, CHIP, 22nH, 0603 SMT, Coilcraft	1
L3	INDUCTOR, CHIP, 1.8nH,0603 SMT, Coilcraft	1
L4	INDUCTOR, CHIP, 33nH, 0603 SMT, Coilcraft	1
L5	INDUCTOR, CHIP, 1.6nH, 0603 SMT, Coilcraft	1
Q1	MMIC, GaN HEMT, DFN3x4, CMPA0530002S	1
	PCB, RO4350B, 0.020 THK, CMPA0530002S	1
	BASEPLATE, AL, 2.60 X 1.7 X 0.25	1
	2-56 SOC HD SCREW 1/4 SS	4
	#2 SPLIT LOCKWASHER SS	4
J1, J2	CONN, SMA, PANEL MOUNT JACK, FLANGE	2
J3	HEADER RT>PLZ .1CEN LK 5POS	1
W1	Wire, Black, 22 AWG, ~ 1"	1

CMPA0530002S-AMP1 Application Circuit

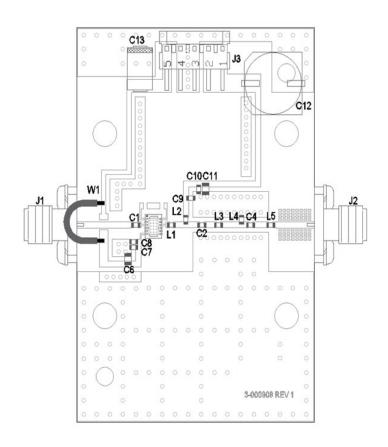




CMPA0530002S-AMP1 Application Circuit Schematic

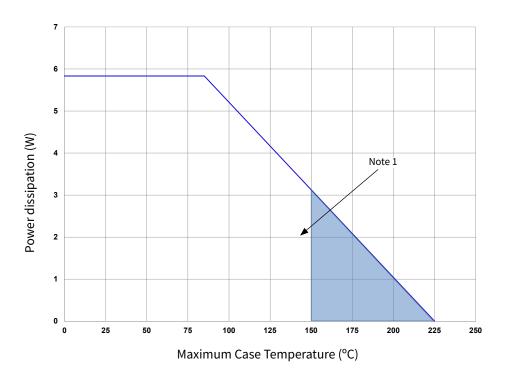


CMPA0530002S-AMP1 Application Circuit Outline





CMPA0530002S Power Dissipation De-rating Curve



Note 1. Area exceeds Maximum Case Temperature (See Page 2)

Electrostatic Discharge (ESD) Classifications

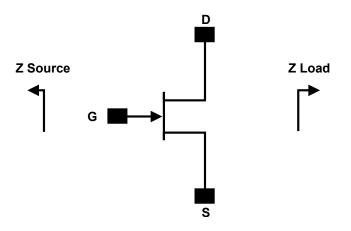
Parameter	Symbol	Class	Classification Level	Test Methodology
Human Body Model	нвм	1A	ANSI/ESDA/JEDEC JS-001 Table 3	JEDEC JESD22 A114-D
Charge Device Model	CDM	C2B	ANSI/ESDA/JEDEC JS-002 Table 3	JEDEC JESD22 C101-C

Moisture Sensitivity Level (MSL) Classification

Parameter	Symbol	Class	Test Methodology
Moisture Sensitivity Level	MSL	3 (168 hours)	IPC/JEDEC J-STD-20



Source and Load Impedances



Frequency (GHz)	Z Source	Z Load
0.5	49.81 - j4.94	120.85 + j24.29
1.0	50.23 - j0.76	65.28 + j15.87
1.5	50.75 + j1.20	70.37 + j20.78
2.0	51.36 + j2.49	62.60 + j23.33
2.5	52.58 + j3.98	51.31 + j44.84
3.0	51.68 + j2.92	60.64 + j75.97

Notes:

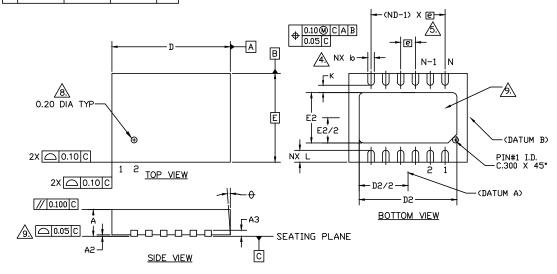
 $^{^{1}}$ V_{DD} = 28V, I_{DQ} = 90mA

² Impedances are extracted from source and load pull data derived from the transistor

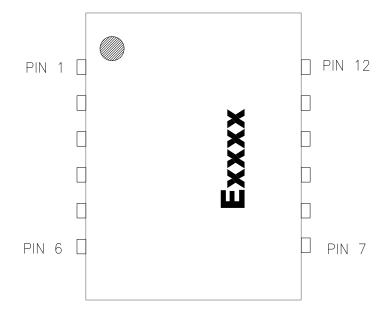


Product Dimensions CMPA0530002S (Package 3 x 4 DFN)

S M B	соммо	No _{TE}			
٥	MIN.	NOM.	MAX.	ŤΕ	
Α	0.80	0.90	1.0		
A1	0.00	0.02	0.05		
Α3	(0.203 REF	•		
Θ	0		12	2	
D	4.00 BSC				
Ε	3.00 BSC				
е	0.50 BSC				
Ν	12				
ND		6		<u>A</u>	
L	0.35	0.40	0.45		
b	0.18	0.25	0.30	<u>A</u>	
D2	3.20	3.30	3.40		
E2	1.60	1.7	1.80		
K	0.20				



Pin	Input/Output
1	NC
2	NC
3	RF IN
4	GND
5	NC
6	V _G
7	NC
8	NC
9	GND
10	RF OUT & V _{DD}
11	NC
12	NC



Note: Leadframe finish for 3x4 DFN package is Nickel/Palladium/Gold. Gold is the outer layer



Part Number System

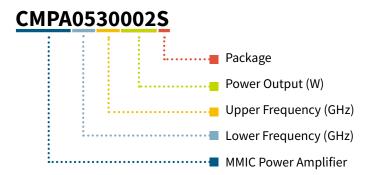


Table 1.

Parameter	Value	Units
Upper Frequency ¹	3.0	GHz
Power Output	2	W
Package	Surface Mount	_

Note

Table 2.

Character Code	Code Value
А	0
В	1
С	2
D	3
E	4
F	5
G	6
Н	7
J	8
К	9
Examples	1A = 10.0 GHz 2H = 27.0 GHz

¹ Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.



Product Ordering Information

Order Number	Description	Unit of Measure	Image
CMPA0530002S	GaN HEMT	Each	5 7 9 9 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8
CMPA0530002S-AMP1	Test board with GaN MMIC installed	Each	



Notes & Disclaimer

MACOM Technology Solutions Inc. ("MACOM"). All rights reserved.

These materials are provided in connection with MACOM's products as a service to its customers and may be used for informational purposes only. Except as provided in its Terms and Conditions of Sale or any separate agreement, MACOM assumes no liability or responsibility whatsoever, including for (i) errors or omissions in these materials; (ii) failure to update these materials; or (iii) conflicts or incompatibilities arising from future changes to specifications and product descriptions, which MACOM may make at any time, without notice. These materials grant no license, express or implied, to any intellectual property rights.

THESE MATERIALS ARE PROVIDED "AS IS" WITH NO WARRANTY OR LIABILITY, EXPRESS OR IMPLIED, RELATING TO SALE AND/OR USE OF MACOM PRODUCTS INCLUDING FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, INFRINGEMENT OF INTELLECTUAL PROPERTY RIGHT, ACCURACY OR COMPLETENESS, OR SPECIAL, INDIRECT, INCIDENTAL, OR CONSEQUENTIAL DAMAGES WHICH MAY RESULT FROM USE OF THESE MATERIALS.

MACOM products are not intended for use in medical, lifesaving or life sustaining applications. MACOM customers using or selling MACOM products for use in such applications do so at their own risk and agree to fully indemnify MACOM for any damages resulting from such improper use or sale.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

MACOM:

CMPA0530002S CMPA0530002S-AMP1